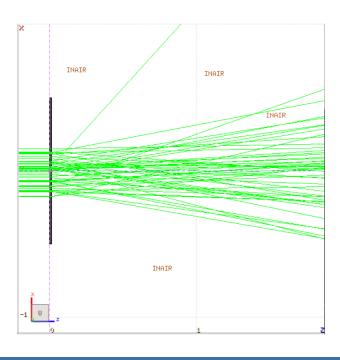


### **Exercise: Thresholds**

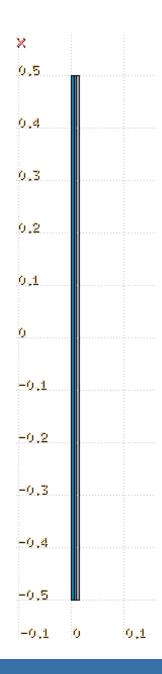
#### Aim of the exercise:

- Examine the effect of setting different threshold values
- Further interaction with the FLUKA manual
- Practice the use of preprocessor directives
- Strengthen plotting skills



### Input file

- 10 MeV electron beam
  - Circular beam with 2 mm radius
- 5-mm radius target split in three layers, each 50 µm thick
  - Set to H<sub>2</sub>O Pb Al
- Thin layers require high tracking precision. Thus, we set
  - **DEFAULT PRECISIOn** (should already be there)
- Notice that three preprocessor variables are defined
  - HI-THR, LOW-THR, VLOW-THR
- USRBIN scoring DOSE over the entire target
  - 1 μm bins in z, 1 μm bins in R, unformatted unit 55



#### Add EMFCUT cards

- Set both production and transport thresholds in all materials
  - Hint: when specifying the range of materials/regions, use @LASTMAT/@LASTREG as needed to refer to the last material or region, respectively
- Threshold cases:

```
#if HI-THR

photons: 1 keV , electrons: 1 MeV kinetic energy, FUDGEM=1

#elif LOW-THR

photons: 1 keV , electrons: 100 keV kinetic energy, FUDGEM=1

#elif VLOW-THR

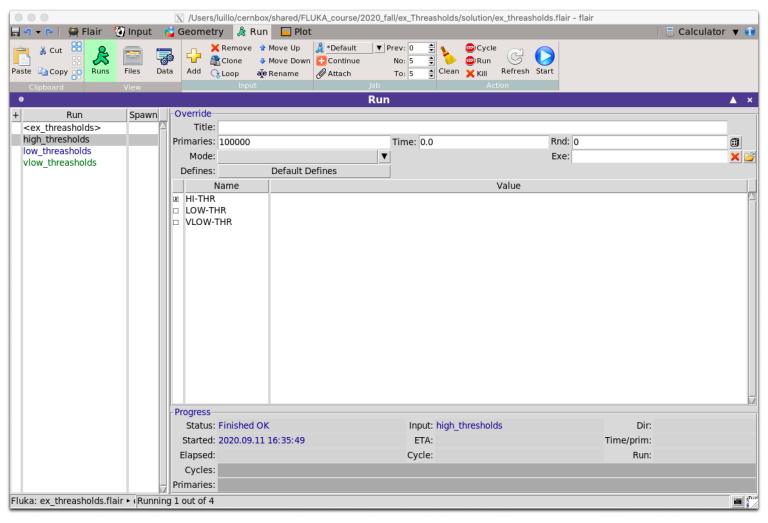
photons: 1 keV , electrons: 10 keV kinetic energy, FUDGEM=0.5

#endif
```

- Note that the electron threshold is 100 keV in case of PRECISION
- Reminder: stopping powers and ranges for electrons, protons, and He ions are available on the NIST webpage: <a href="https://physics.nist.gov/PhysRefData/Star/Text/intro.html">https://physics.nist.gov/PhysRefData/Star/Text/intro.html</a>



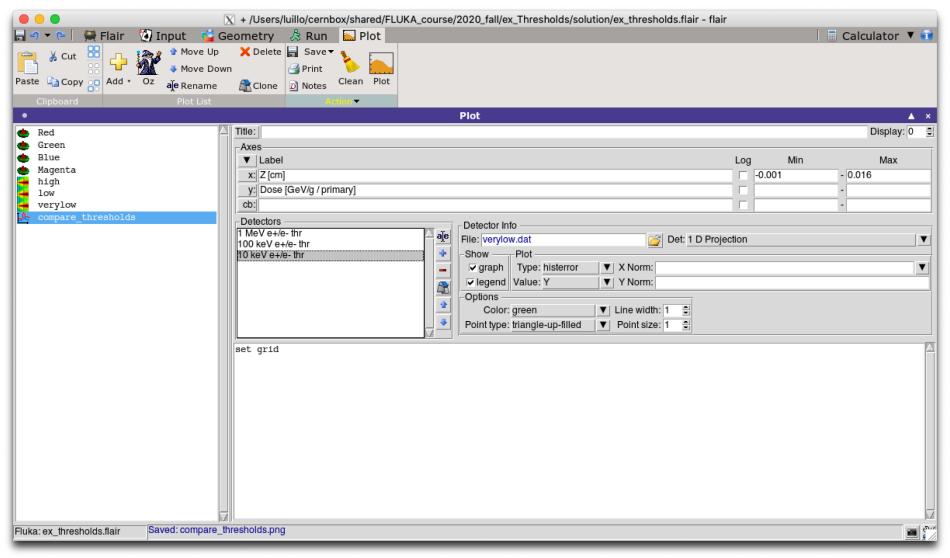
### Run



Run three simulations corresponding to high, low, or very low threshold values, with 5 cycles × 100000 primaries for each case. The three runs are already set up in the Flair project. Should take less than ~5 minutes on a reasonable machine.



# Plot and compare the results



The plots are already set up in the Flair project



## **Result: Compare thresholds**

